MOSFET – Power, Single, P-Channel, SOT-223

-60 V, -2.6 A

NTF2955, NVF2955

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX
–60 V	145 mΩ @ –10 V	–2.6 A

Features
- Design for low $R_{DS(on)}$
- Withstands High Energy in Avalanche and Commutation Modes
- AEC−Q101 Qualified − NVF2955
- These Devices are Pb−Free and are RoHS Compliant

Applications
- Power Supplies
- PWM Motor Control
- Converters
- Power Management

P−Channel
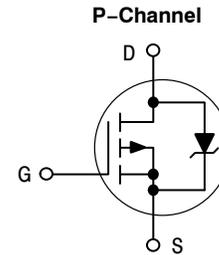
MARKING DIAGRAM AND PIN ASSIGNMENT

SOT−223
CASE 318E
STYLE 3

A   = Assembly Location
Y   = Year
W   = Work Week
▪   = Pb−Free Package
(Note: Microdot may be in either location)

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	–60	V
Gate−to−Source Voltage			V_{GS}	±20	V
Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	–2.6	A
		T_A = 85°C		–2.0	
Power Dissipation (Note 1)	Steady State	T_A = 25°C	P_D	2.3	W
Continuous Drain Current (Note 2)	Steady State	T_A = 25°C	I_D	–1.7	A
		T_A = 85°C		–1.3	
Power Dissipation (Note 2)		T_A = 25°C	P_D	1.0	W
Pulsed Drain Current	tp = 10 μs		I_{DM}	–17	A
Operating Junction and Storage Temperature			T_J, T_{STG}	–55 to 175	°C
Single Pulse Drain−to−Source Avalanche Energy (V_{DD} = 25 V, V_G = 10 V, I_{PK} = 6.7 A, L = 10 mH, R_G = 25 Ω)			EAS	225	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 seconds)			T_L	260	°C

THERMAL RESISTANCE RATINGS

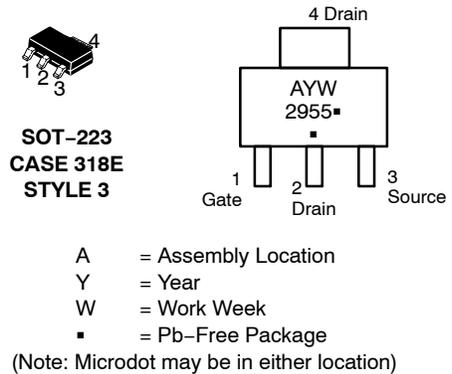| Parameter	Symbol	Max	Unit
Junction−to−Tab (Drain) − Steady State (Note 2)	$R_{θJC}$	14	°C/W
Junction−to−Ambient − Steady State (Note 1)	$R_{θJA}$	65	
Junction−to−Ambient − Steady State (Note 2)	$R_{θJA}$	150	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. When surface mounted to an FR4 board using 1 in. pad size (Cu. area = 1.127 in² [1 oz] including traces).
2. When surface mounted to an FR4 board using the minimum recommended pad size (Cu. area = 0.341 in²)

ORDERING INFORMATION

Device	Package	Shipping[†]
NTF2955T1G	SOT−223 (Pb−Free)	1000 /Tape & Reel
NVF2955T1G	SOT−223 (Pb−Free)	1000/ Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

December, 2024 – Rev. 8

Publication Order Number:
NTF2955/D

ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain−to−Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = −250 μA		−60	–	–	V
Drain−to−Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$			–	66.4	–	mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = −60 V	T_J = 25°C	–	–	−1.0	μA
			T_J = 125°C	–	–	−50	
Gate−to−Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V		–	–	±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = −1.0 mA		−2.0	–	−4.0	V
Drain−to−Source On Resistance	$R_{DS(on)}$	V_{GS} = −10 V, I_D = −0.75 A		–	145	170	mΩ
		V_{GS} = −10 V, I_D = −1.5 A		–	150	180	
		V_{GS} = −10 V, I_D = −2.4 A		–	154	185	
Forward Transconductance	g_{FS}	V_{GS} = −15 V, I_D = −0.75 A		–	1.77		S
CHARGES AND CAPACITANCES							
Input Capacitance	C_{ISS}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V		–	492	–	pF
Output Capacitance	C_{OSS}			–	165	–	
Reverse Transfer Capacitance	C_{RSS}			–	50	–	
Total Gate Charge	$Q_{G(TOT)}$	V_{GS} = 10 V, V_{DS} = 30 V, I_D = 1.5 A		–	14.3	–	nC
Threshold Gate Charge	$Q_{G(TH)}$			–	1.2	–	
Gate−to−Source Charge	Q_{GS}			–	2.3	–	
Gate−to−Drain Charge	Q_{GD}			–	5.2	–	
SWITCHING CHARACTERISTICS (Note 4)							
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = 10 V, V_{DD} = 25 V, I_D = 1.5 A, R_G = 9.1 Ω R_L = 25 Ω		–	11	–	ns
Rise Time	t_r			–	7.6	–	
Turn−Off Delay Time	$t_{d(OFF)}$			–	65	–	
Fall Time	t_f			–	38	–	
DRAIN−SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	V_{GS} = 0 V, I_S = 1.5 A	T_J = 25°C	–	−1.10	−1.30	V
			T_J = 125°C	–	−0.9	–	
Reverse Recovery Time	t_{RR}	V_{GS} = 0 V, dI_S/dt = 100 A/μs, I_S = 1.5 A		–	36	–	ns
Charge Time	t_a			–	20	–	
Discharge Time	t_b			–	16	–	
Reverse Recovery Charge	Q_{RR}			–	0.139	–	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Pulse Test: pulse width ≤ 300μs, duty cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

NTF2955, NVF2955

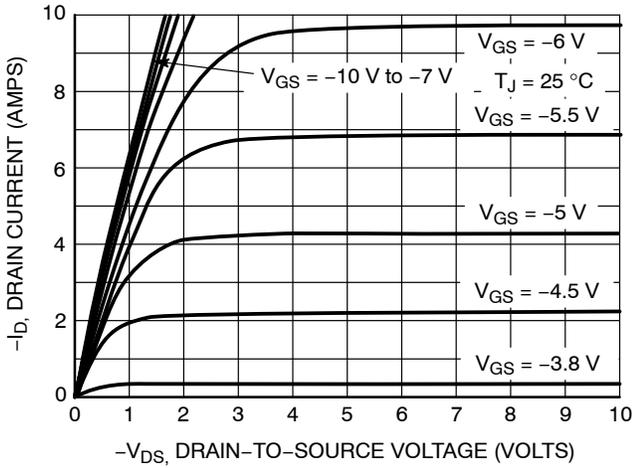## TYPICAL PERFORMANCE CURVES (T$_J$ = 25°C UNLESS OTHERWISE NOTED)
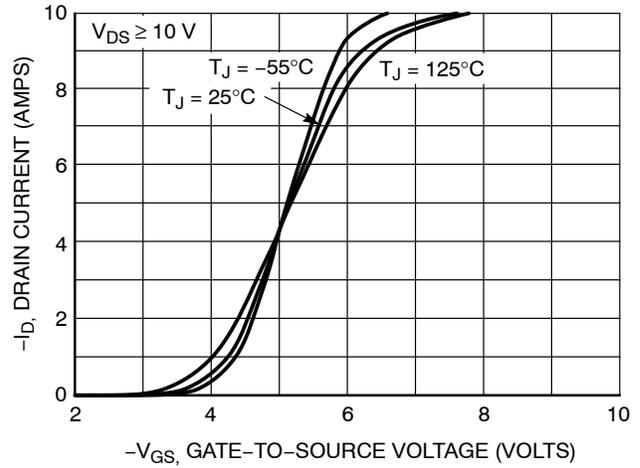

Figure 1. On−Region Characteristics

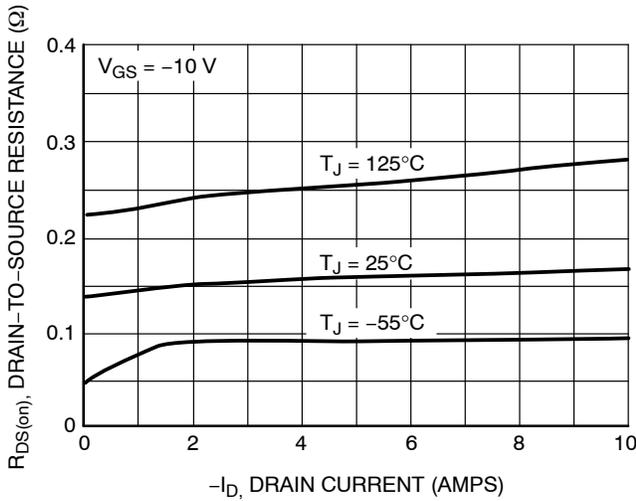Figure 2. Transfer Characteristics

Figure 3. On−Resistance versus Drain Current and Temperature
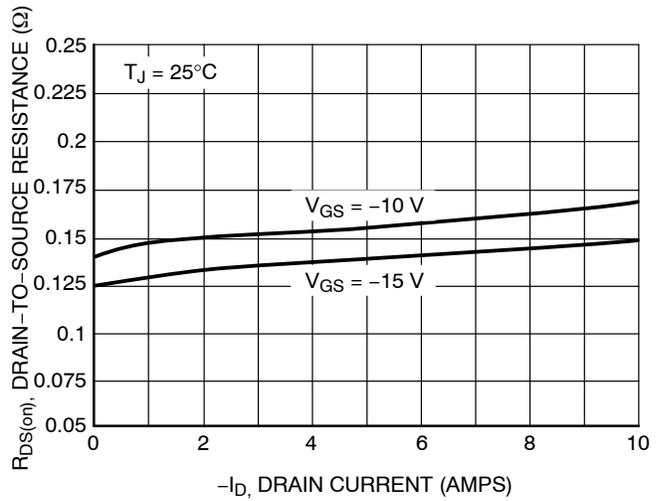

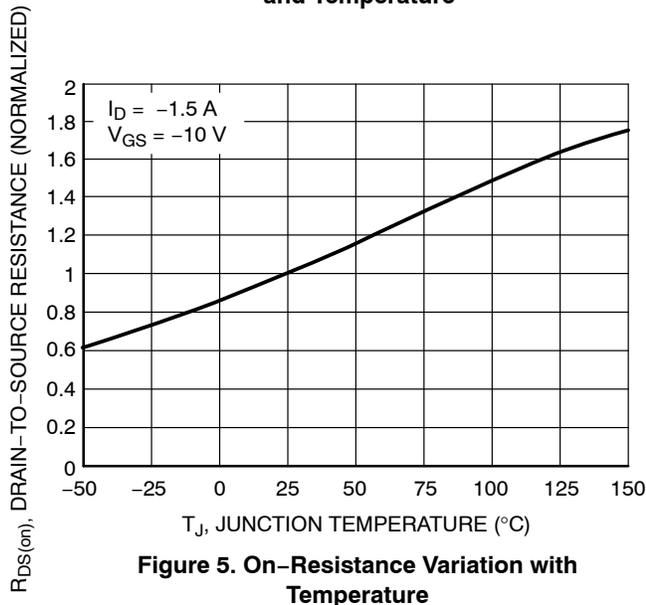Figure 4. On−Resistance versus Drain Current and Gate Voltage
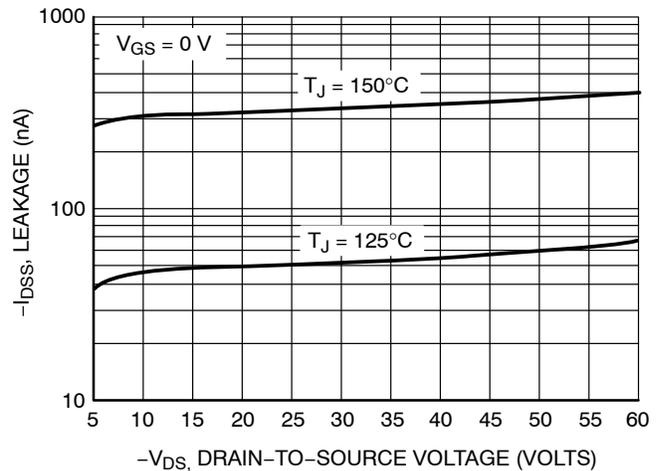

Figure 5. On−Resistance Variation with Temperature

Figure 6. Drain−to−Source Leakage Current versus Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C UNLESS OTHERWISE NOTED)
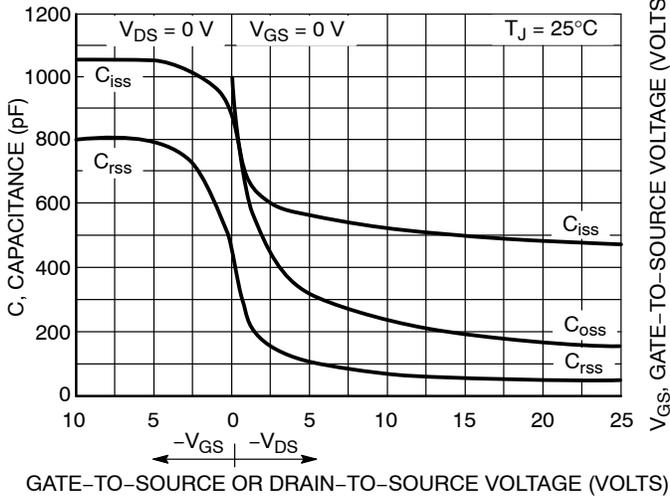
Figure 7. Capacitance Variation
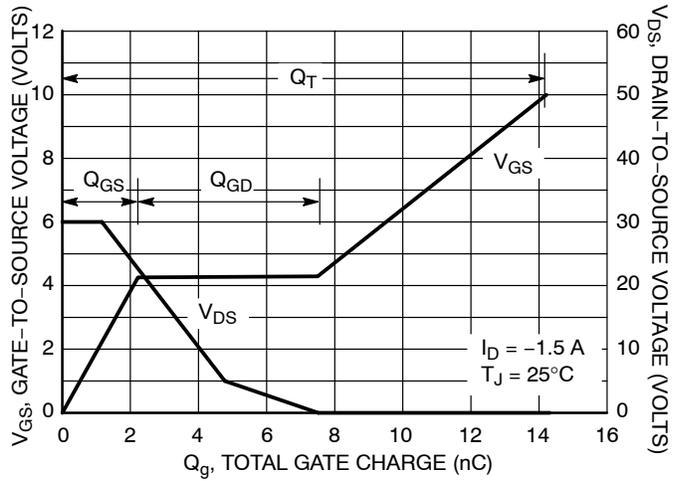
Figure 8. Gate–to–Source and Drain–to–Source Voltage versus Total Charge
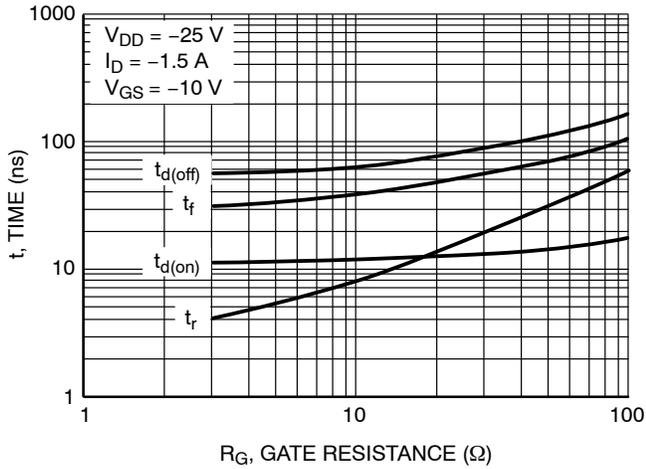
Figure 9. Resistive Switching Time Variation versus Gate Resistance
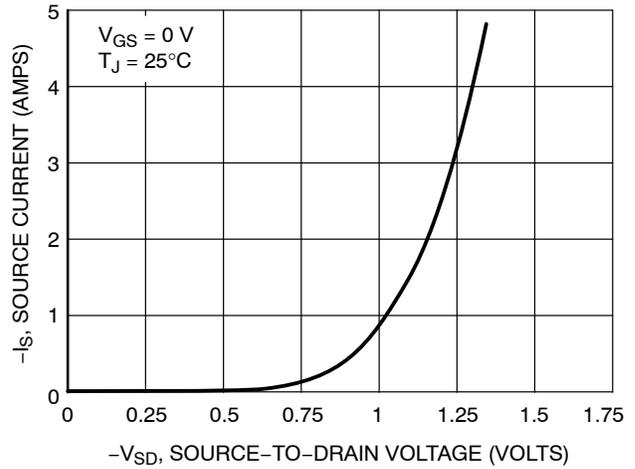
Figure 10. Diode Forward Voltage versus Current
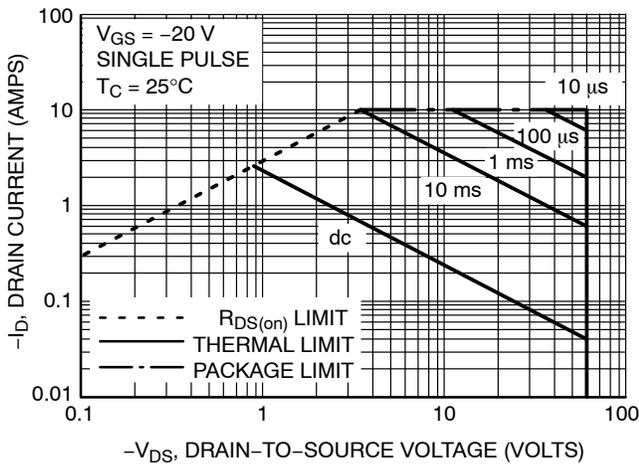
Figure 11. Maximum Rated Forward Biased Safe Operating Area
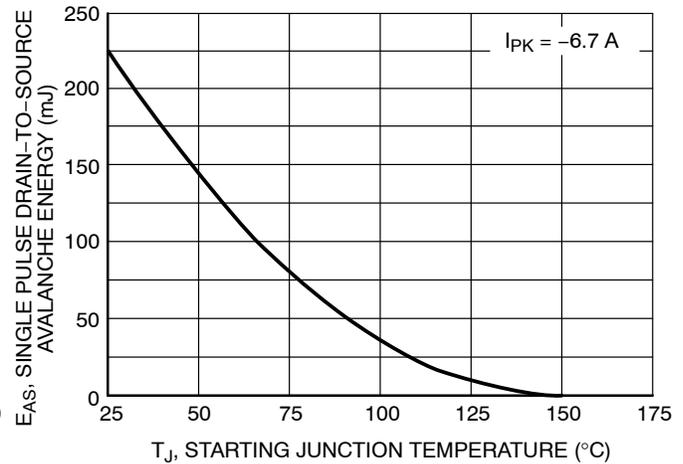
Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature
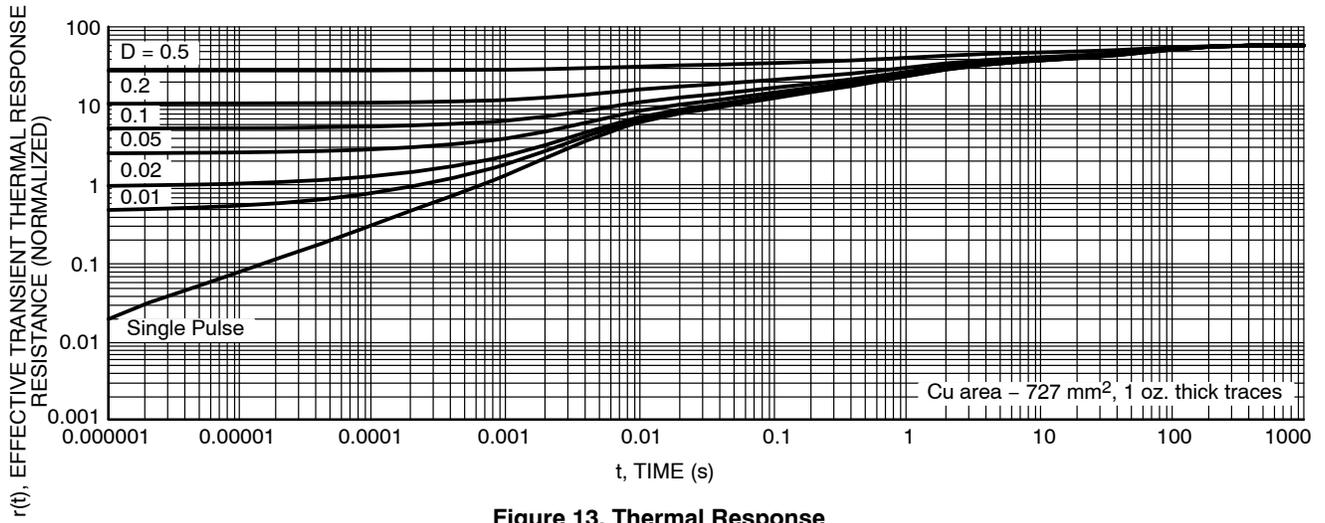
Figure 13. Thermal Response

ADDITIONAL INFORMATION

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